# MOSFET - Single, N-Channel, Small Signal, SOT-883 (XDFN3), 1.0 x 0.6 x 0.4 mm 30 V, 1000 mA

## NTNS4C69N

### **Features**

- Single N-Channel MOSFET
- Ultra Low Profile SOT–883 (XDFN3) 1.0 x 0.6 x 0.4 mm for Extremely Thin Environments such as Portable Electronics
- Low R<sub>DS(on)</sub> Solution in Ultra Small 1.0 x 0.6 mm Package
- 1.8 V Gate Drive
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### **Applications**

- High Side Switch
- High Speed Interfacing
- Level Shift and Translate
- Optimized for DC-DC Converter Power Management in Ultra Portable Solutions

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter		Symbol	Value	Units	
Drain-to-Source Voltage		$V_{DSS}$	30	V	
Gate-to-Source Voltage		$V_{GS}$	±12	V	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	$I_{D}$	1000	mA
Current (Note 1)	State	T <sub>A</sub> = 85°C		721	
	t ≤ 5 s	T <sub>A</sub> = 25°C		1050	
Power Dissipa- tion (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	178	mW
	t ≤ 5 s	T <sub>A</sub> = 25°C		187	
Pulsed Drain Current $t_p = 10 \mu s$		I <sub>DM</sub>	2.6	Α	
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C	
Source Current (Body Diode) (Note 2)		I <sub>S</sub>	187	mA	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	703	°C/W
Junction-to-Ambient – t ≤ 5 s (Note 1)	$R_{\theta JA}$	670	

- 1. Surface Mounted on FR4 Board using the minimum recommended pad size, (or 2  $\mathrm{mm^2}$ ), 1 oz Cu.
- 2. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.



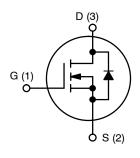
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### **MOSFET**

V <sub>(BR)DSS</sub>	V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> MAX	
	0.155 Ω @ 4.5 V	
	0.168 Ω @ 3.7 V	
30 V	0.180 Ω @ 3.3 V	1000 mA
	0.220 Ω @ 2.5 V	
	0.450 Ω @ 1.8 V	

### **N-Channel MOSFET**





### SOT-883 (XDFN3) CASE 506CB



**MARKING** 

AA = Specific Device Code M = Date Code

### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTNS4C69NTCG	SOT-883 (Pb-Free)	8000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

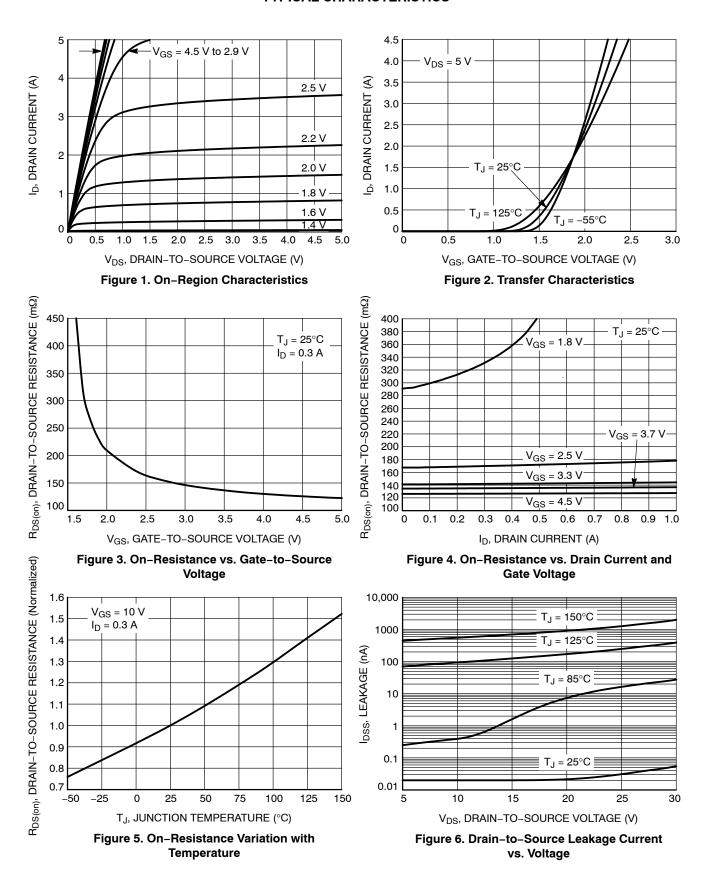
### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS		•		•	•		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μΑ	A, ref to 25°C		17		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C			1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 12 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$	<sub>S</sub> , I <sub>D</sub> = 10 μA	0.65		1.1	V
Negative Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-3.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 300 \text{ mA}$			0.127	0.155	Ω
		V <sub>GS</sub> = 3.7 V	/, I <sub>D</sub> = 250 mA		0.135	0.168	
		V <sub>GS</sub> = 3.3 V	/, I <sub>D</sub> = 200 mA		0.140	0.180	
		V <sub>GS</sub> = 2.5 V	/, I <sub>D</sub> = 150 mA		0.170	0.220	
		V <sub>GS</sub> = 1.8 V	/, I <sub>D</sub> = 100 mA		0.300	0.450	
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_D = 200 \text{ mA}$			2.0		S
Source-Drain Diode Voltage	$V_{SD}$	$V_{GS} = 0 V$	I <sub>S</sub> = 100 mA		0.7	1.0	V
CHARGES & CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				75		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,} $ $V_{DS} = 15 \text{ V}$			34		
Reverse Transfer Capacitance	C <sub>RSS</sub>				3.0		
Total Gate Charge	$Q_{G(TOT)}$				0.9		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V	′, V <sub>DS</sub> = 15 V,		0.1		
Gate-to-Source Charge	$Q_{GS}$	I <sub>D</sub> = 200 mA			0.2		
Gate-to-Drain Charge	$Q_{GD}$				0.1		
SWITCHING CHARACTERISTICS, VG	<b>S</b> = <b>4.5 V</b> (Note 3)						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 4.5 V, $V_{DD}$ = 15 V, $I_{D}$ = 200 mA, $R_{G}$ = 2 $\Omega$			4.5		ns
Rise Time	t <sub>r</sub>				3.5		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				9.0		
Fall Time	t <sub>f</sub>				7.0		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**



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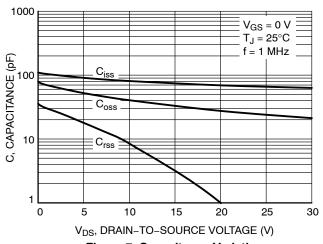


Figure 7. Capacitance Variation

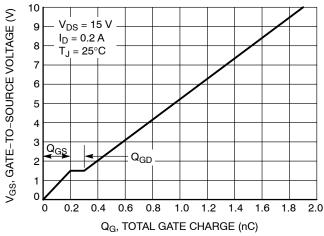


Figure 8. Gate-to-Source vs. Total Charge

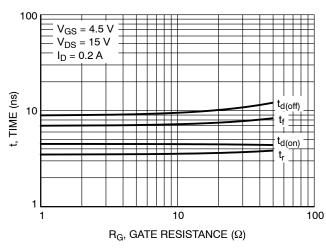


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

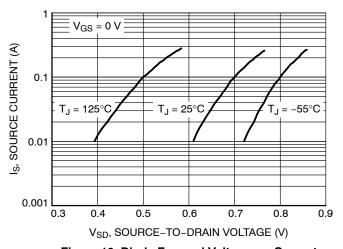


Figure 10. Diode Forward Voltage vs. Current

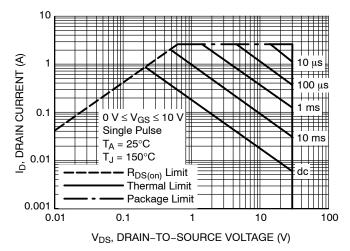


Figure 11. Safe Operating Area

### **TYPICAL CHARACTERISTICS**

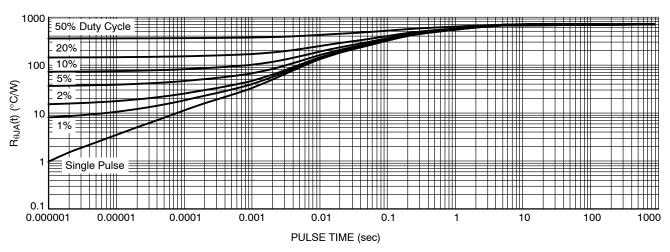
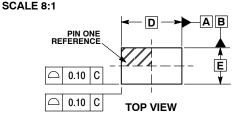


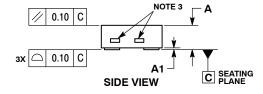
Figure 12. Thermal Characteristics

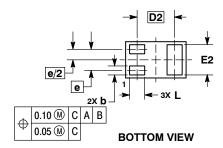


### SOT-883 (XDFN3), 1.0x0.6, 0.35P CASE 506CB **ISSUE A**

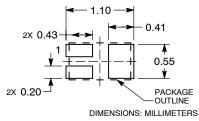
**DATE 30 MAR 2012** 







### **RECOMMENDED SOLDER FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
- 3. EXPOSED COPPER ALLOWED AS SHOWN.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.340	0.440		
A1	0.000 0.030			
b	0.075	0.200		
D	0.950	1.075		
D2	0.620 BSC			
е	0.350 BSC			
E	0.550	0.675		
E2	0.425	0.550		
L	0.170	0.300		

### **GENERIC MARKING DIAGRAM\***



XX = Specific Device Code

= Date Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G", may or not be present.

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